

Enclosures: PTO-1449, w/references

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

<b>Attorney Docket Number</b>	<b>42637/GDL/N288</b>
Application Number	To be assigned
Filing Date	December 17, 2001
Applicant(s)	Jayant Neogi
Group Art Unit	To be determined
Examiner Name	To be determined

**FOREIGN PATENT DOCUMENTS**

EXAMINER INITIALS	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	WO 99/34197	07/1999	WIPO				
	2033096A	05/1980	GB	G03B	41/00		

**OTHER DOCUMENTS**

EXAMINER INITIALS	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
	BRAUNSTEIN, et al., Depth profile of antimony implanted into diamond, Journal of Applied Physics, Vol. 50, No. 9, September 1979, Pgs. 5731 - 5735.
	ENDENFELD et al., Force probe characterization using silicon three-dimensional structures formed by focused ion beam lithography, Journal of Vacuum Science and Technology B, Vol. 12, No. 6, 1994, Pgs. 3571-3575.
	KOMURO, Ion Beam Exposure Apparatus Using Liquid Metal Source, 1982, Pgs. 155-159, Elsevier Squoia; Netherlands
	International Search Report for PCT/US00/16761 Dated October 2, 2000

EXAMINER SIGNATURE		DATE CONSIDERED	
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

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**U.S. PATENT DOCUMENTS**

EXAMINER INITIALS	DOCUMENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	3,840,721	10/1974	Monk	219	121	
	3,908,183	09/1975	Ennis, Jr.	357	65	
	4,334,139	06/1982	Wittecock et al.	219	121.3	
	4,392,476	07/1983	Gresser et al.	125	30 R	
	4,401,876	08/1983	Cooper	219	121 LJ	
	4,425,796	01/1984	Hakoune	63	32	
	4,450,041	05/1984	Aklufi	156	628	
	4,457,803	07/1984	Takigawa	156	626	
	4,467,172	08/1984	Ehrenwald et al.	219	121 LH	
	4,698,129	10/1987	Puretz et al.	156	643	
	4,809,417	03/1989	Normann, Jr.	29	160.6	
	4,869,780	09/1989	Yang et al.	156	643	
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	4,999,083	03/1991	Watanabe et al.	156	628	
	4,999,234	03/1991	Cowan	428	156	
	5,149,938	09/1992	Winston et al.	219	121.69	
	5,354,420	10/1994	Russell et al.	156	643	
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	5,402,410	03/1995	Yoshimura et al.	369	275.1	
	5,423,714	06/1995	Lach	451	57	
	5,453,594	09/1995	Konecny	219	121.61	
	5,721,687	02/1998	Lamartine et al.	364	474.08	
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	5,760,367	06/1998	Rosenwasser et al.	219	121.69	
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